

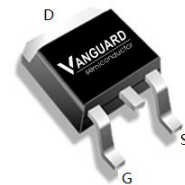
Features

- P-Channel, -5V Logic Level Control
- Low on-resistance RDS(on) @ VGS=-4.5 V
- Fast Switching
- Enhancement mode
- 100% Avalanche Tested
- Pb-free lead plating; RoHS compliant


Halogen-Free

Part ID	Package Type	Marking	Tape and reel information
VS3504AD	TO-252	3504AD	2500PCS/Reel

V_{DS}	-30	V
$R_{DS(on),TYP} @ V_{GS}=-10 V$	5	mΩ
$R_{DS(on),TYP} @ V_{GS}=-4.5V$	7.2	mΩ
I_D	-115	A

TO-252


Drain Pin 2



Source Pin 3

Maximum ratings, at T_A =25 °C, unless otherwise specified

Symbol	Parameter	Rating	Unit	
$V_{(BR)DSS}$	Drain-Source breakdown voltage	-30	V	
V _{GS}	Gate-Source voltage	±20	V	
I_S	Diode continuous forward current	T _C =25°C	-115	A
I_D	Continuous drain current @V _{GS} =-10V	T _C =25°C	-115	A
		T _C =100°C	-82	A
I_{DM}	Pulse drain current tested ①	T _C =25°C	-460	A
I_{DSM}	Continuous drain current @V _{GS} =10V	T _A =25°C	13	A
		T _A =70°C	10	A
EAS	Avalanche energy, single pulsed ②	91	mJ	
P_D	Maximum power dissipation	T _C =25°C	100	W
P_{DSM}	Maximum power dissipation ③	T _A =25°C	1.25	W
T _{STG} T _J	Storage and Junction Temperature Range	-55 to 175	°C	
Thermal Characteristics				
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.5	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	°C/W	

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_J = 25°C (unless otherwise stated)						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-30	--	--	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V	--	--	-1	μA
	Zero Gate Voltage Drain Current(T _J =125°C)	V _{DS} =-30V, V _{GS} =0V	--	--	-100	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250μA	-1.0	--	-2.5	V
R _{DS(ON)}	Drain-Source On-State Resistance ④	V _{GS} =-10V, I _D =-30A	--	5	7	mΩ
R _{DS(ON)}	Drain-Source On-State Resistance ④	V _{GS} =-4.5V, I _D =-20A	--	7.2	10	mΩ
Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise stated)						
C _{iss}	Input Capacitance	V _{DS} =-15V, V _{GS} =0V, f=1MHz	3900	4900	5900	pF
C _{oss}	Output Capacitance		500	725	950	pF
C _{rss}	Reverse Transfer Capacitance		300	460	620	pF
R _g	Gate Resistance	f=1MHz	--	10.2	--	Ω
Q _g	Total Gate Charge	V _{DS} =-15V, I _D =-30A, V _{GS} =-10V	--	89	--	nC
Q _{gs}	Gate-Source Charge		--	14.8	--	nC
Q _{gd}	Gate-Drain Charge		--	19	--	nC
Switching Characteristics						
t _{d(on)}	Turn-on Delay Time	V _{DD} =-15V, I _D =-30A, R _G =3.0Ω, V _{GS} =-10V	--	182	--	nS
t _r	Turn-on Rise Time		--	262	--	nS
t _{d(off)}	Turn-Off Delay Time		--	3.2	--	nS
t _f	Turn-Off Fall Time		--	11.7	--	nS
Source- Drain Diode Characteristics @ T_J = 25°C (unless otherwise stated)						
V _{SD}	Forward on voltage	I _{SD} =-20A, V _{GS} =0V	--	-0.8	-1.2	V
t _{rr}	Reverse Recovery Time	T _J =25°C, I _{sd} =-30A, V _{GS} =0V	--	34	--	nS
Q _{rr}	Reverse Recovery Charge		di/dt=-300A/μs		79	

NOTE:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax}, starting T_J = 25°C, L = 0.5mH, R_G = 25Ω, I_{AS} = -15A, V_{GS} = -10V. Part not recommended for use above this value
- ③ The power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150°C.
- ④ Pulse width ≤ 300μs; duty cycles ≤ 2%.

Typical Characteristics

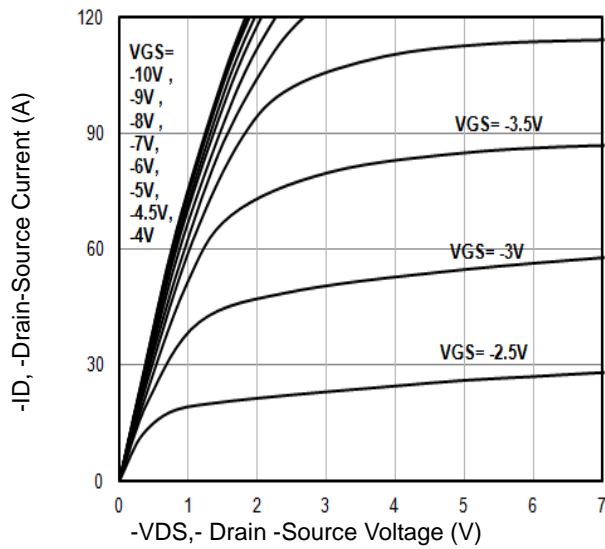


Fig1. Typical Output Characteristics

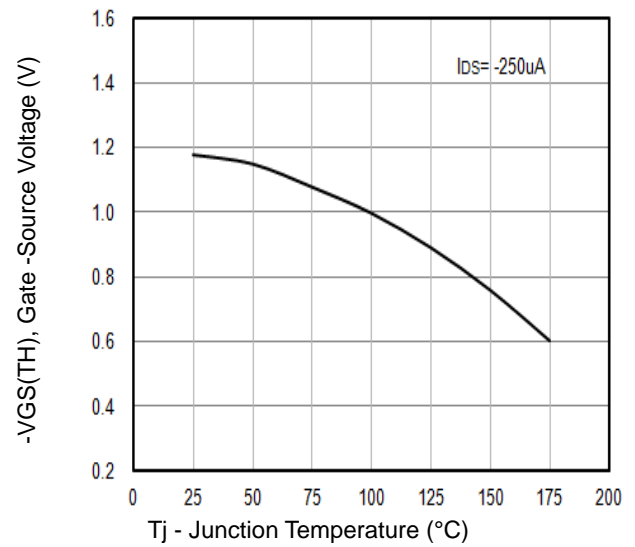


Fig2. $-V_{GS(TH)}$ Gate -Source Voltage Vs. T_j

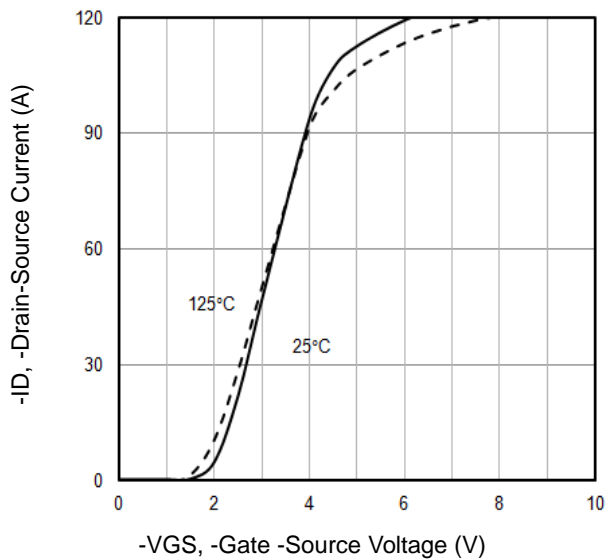


Fig3. Typical Transfer Characteristics

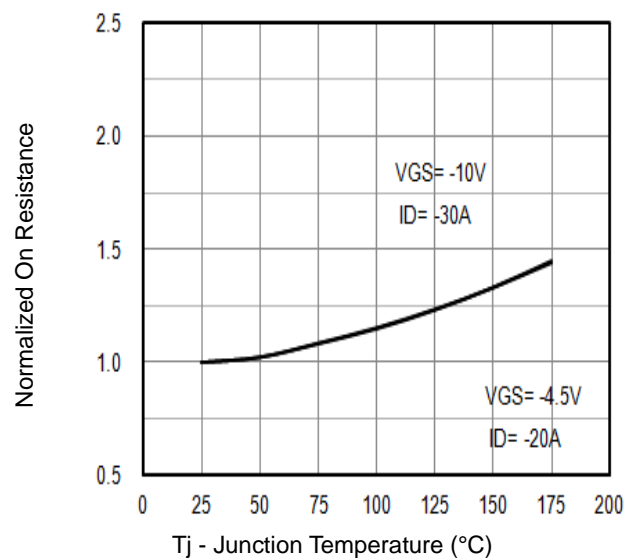


Fig4. Normalized On-Resistance Vs. T_j

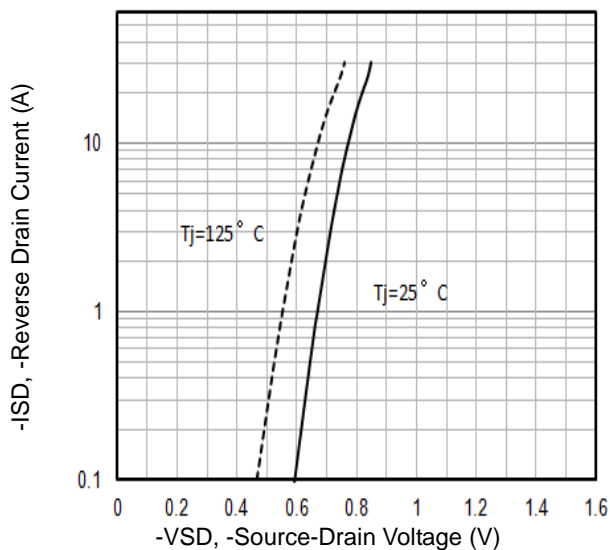


Fig5. Typical Source-Drain Diode Forward Voltage

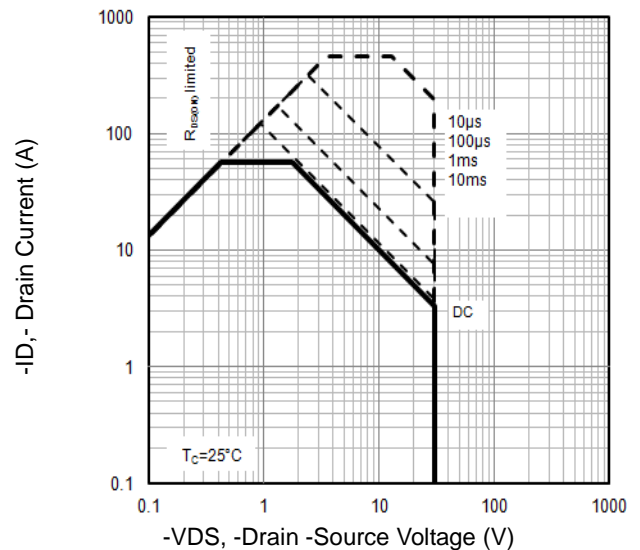


Fig6. Maximum Safe Operating Area

Typical Characteristics

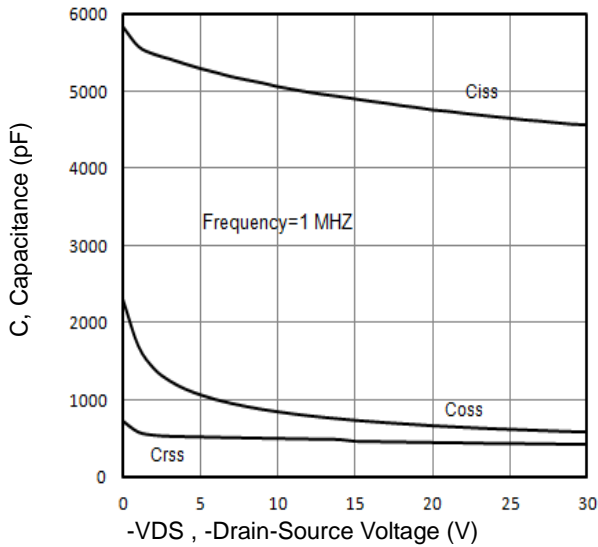


Fig7. Typical Capacitance Vs.Drain-Source Voltage

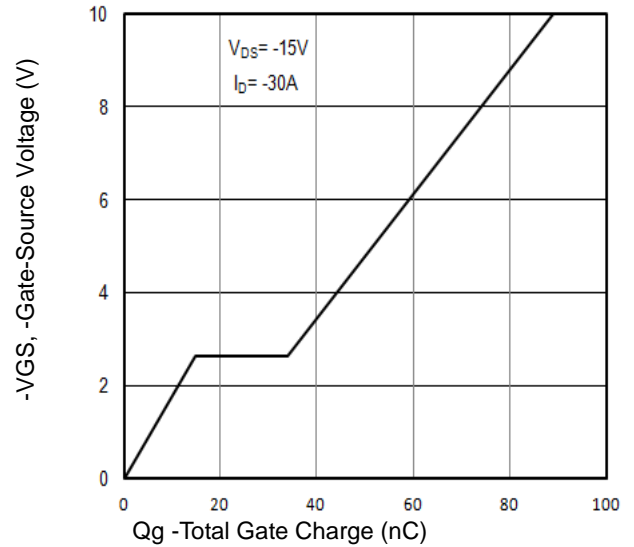


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

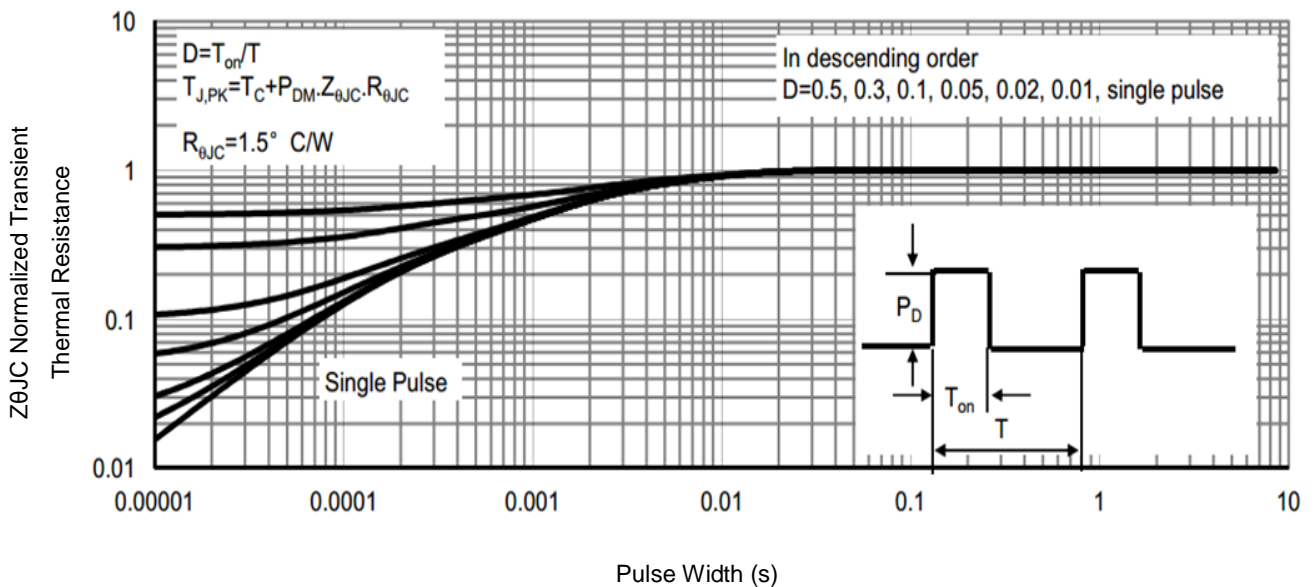


Fig9. Normalized Maximum Transient Thermal Impedance

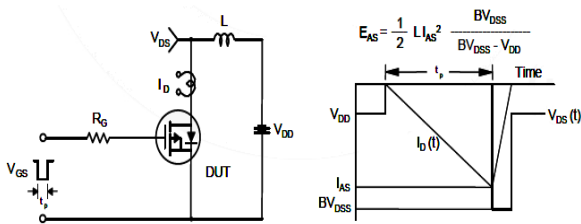


Fig10. Unclamped Inductive Test Circuit and Waveforms

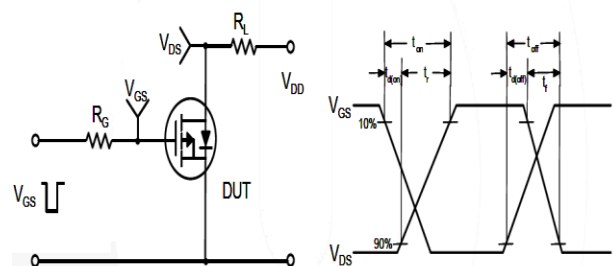
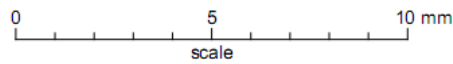
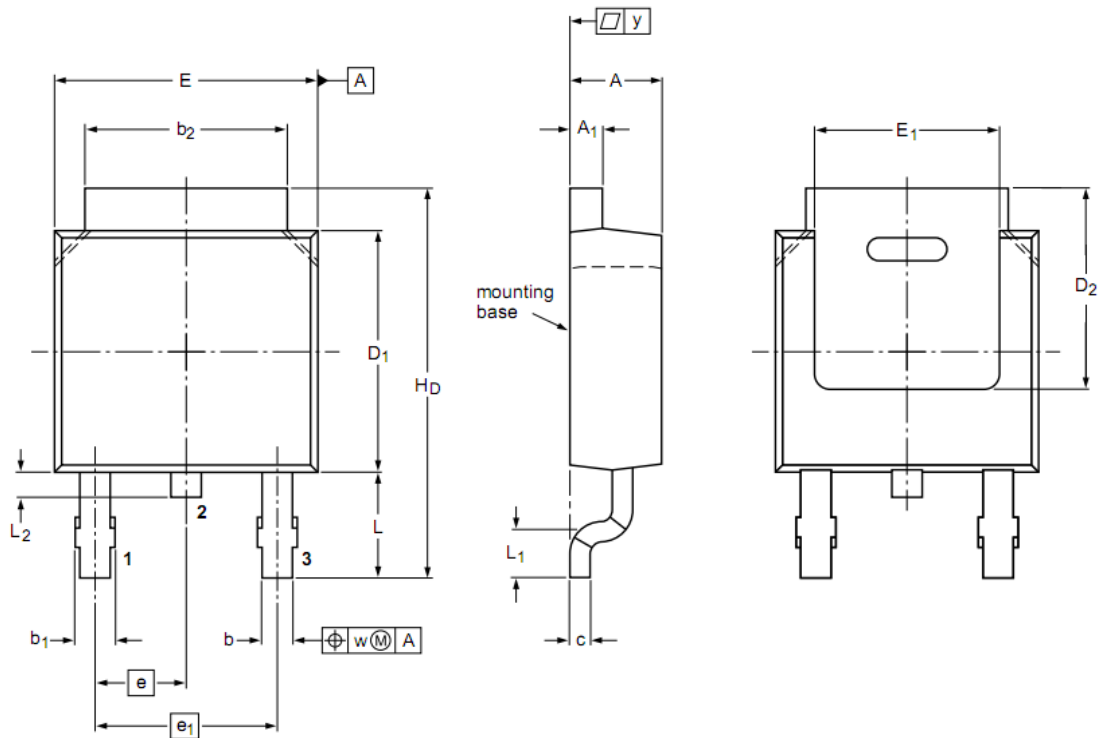


Fig11. Switching Time Test Circuit and waveforms



TO-252 Package Outline Data



Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	2.20	2.30	2.38
A ₁	0.46	0.50	0.63
b	0.64	0.76	0.89
b ₁	0.77	0.85	1.14
b ₂	5.00	5.33	5.46
c	0.458	0.508	0.558
D ₁	5.98	6.10	6.223
D ₂	5.21	--	--
E	6.40	6.60	6.731
E ₁	4.40	--	--
e	2.286 BSC		
e ₁	--	4.57	--
H _D	9.40	10.00	10.40
L	2.743 REF		
L ₁	1.40	1.52	1.77
L ₂	0.50	0.80	1.01
w	--	0.20	--
y	--	--	0.20

Notes:

1. Refer to JEDEC TO-252 variation AA
2. Dimension "E" does NOT include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.1524mm per side.
3. Dimension "D1" does NOT include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.1524mm per end.

Customer Service

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